Diffuse Interface Field Approach (DIFA) to Modeling and Simulation of Particle-based Materials Processes

Yu U. Wang

Materials Science and Engineering Department Michigan Technological University

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Motivation

Extend phase field method to model free-body solid particles

Outline

Interesting and important issues in particle processes

- Moving particles of arbitrary shapes and sizes in close distance: rigid-body translations and rotations
- Short-range forces: mechanical contact, friction, cohesion, steric repulsion, Stokes drag (particle shape matters)
- Long-range forces: electric charge, charge heterogeneity, electric double layer, electric/magnetic dipole, van der Waals (point-charge/point-dipole approximation inaccurate)
- External forces: electric/magnetic field, gravity (field-directed self-assembly)
- Multi-phase liquid: fluid interface evolution, capillary force on particles (surface tension, Laplace pressure via Gibbs-Duhem relation) PFM2014, State College, PA Materials Science and Engineering

Diffuse interface field description: arbitrary particle shape, continuous motion on discrete computational grids, as desired for dynamic simulation



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Short-range forces: mechanical contact, steric repulsion

$$d\mathbf{F}^{\mathrm{sr}}(\mathbf{r};\alpha) = \kappa \sum_{\alpha' \neq \alpha} \eta(\mathbf{r};\alpha) \eta(\mathbf{r};\alpha') \Big[\nabla \eta(\mathbf{r};\alpha) - \nabla \eta(\mathbf{r};\alpha') \Big] d^{3}r$$

action-reaction symmetry



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☐ Total force and torque acting on individual particle

 $\mathbf{F}(\alpha) = \mathbf{F}^{\mathrm{sr}}(\alpha) + \boldsymbol{\xi}^{\mathrm{f}}(\alpha)$ $\mathbf{T}(\alpha) = \mathbf{T}^{\mathrm{sr}}(\alpha) + \boldsymbol{\xi}^{\mathrm{t}}(\alpha)$

thermal noise for Brownian motion

Particle dynamics in viscous liquid $V_i(\alpha) = M_{ij}(\alpha)F_j(\alpha)$ small Reynolds number Re<<1, $\Omega_i(\alpha) = N_{ij}(\alpha)T_j(\alpha)$ Stokes drag (friction), mobility

□ Equation of motion $\eta(\mathbf{r},t;\alpha) = \eta(\mathbf{r}^{0},t_{0};\alpha)$ mapping without $r_{i} = Q_{ij}(t;\alpha) [r_{j}^{0} - r_{j}^{c}(t_{0};\alpha)] + r_{i}^{c}(t;\alpha)$ error accumulation $r_{i}^{c}(t+dt;\alpha) = r_{i}^{c}(t;\alpha) + V_{i}(t;\alpha)dt$ translation $Q_{ij}(t+dt;\alpha) = R_{ik}(t;\alpha) Q_{kj}(t;\alpha)$ rotation $R_{ij}(t;\alpha) = \delta_{ij}\cos\omega + m_{i}m_{j}(1-\cos\omega) - \varepsilon_{ijk}m_{k}\sin\omega$ incremental rotation *PFM2014, State College, PA* Materials Science and Engineering

Particle sedimentation and stacking



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Particle sedimentation and stacking



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Phase field model of solid-state sintering: rigid-body motions



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□ Long-range force: charged particles

 $\rho(\mathbf{r},t;\alpha) = \rho(\alpha) \eta(\mathbf{r},t;\alpha) \qquad \text{body charge}$ $\rho(\mathbf{r},t;\alpha) = \rho(\alpha) \eta(\mathbf{r},t;\alpha) [1 - \eta(\mathbf{r},t;\alpha)] \qquad \text{surface charge}$

$$\rho(\mathbf{r},t) = \sum_{\alpha} \rho(\mathbf{r},t;\alpha) \qquad \mathbf{E}(\mathbf{r}) = \mathbf{E}^{\mathrm{ex}} - \frac{i}{\varepsilon_0} \int \frac{d^3k}{(2\pi)^3} \frac{\tilde{\rho}(\mathbf{k})}{k} \mathbf{n} e^{i\mathbf{k}\cdot\mathbf{r}}$$
$$\mathbf{F}^{\mathrm{el}}(\alpha) = \int_V \mathbf{E}(\mathbf{r}) \,\rho(\mathbf{r};\alpha) \, d^3r \qquad \mathbf{T}^{\mathrm{el}}(\alpha) = \int_V \left[\mathbf{r} - \mathbf{r}^{\mathrm{c}}(\alpha)\right] \times \mathbf{E}(\mathbf{r}) \,\rho(\mathbf{r};\alpha) \, d^3r$$



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Long-range force: charged particles

 $\rho(\mathbf{r},t;\alpha) = \rho(\alpha) \eta(\mathbf{r},t;\alpha) \qquad \text{body charge}$ $\rho(\mathbf{r},t;\alpha) = \rho(\alpha) \eta(\mathbf{r},t;\alpha) [1 - \eta(\mathbf{r},t;\alpha)] \qquad \text{surface charge}$

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Total force and torque acting on individual particle $\mathbf{F}(\alpha) = \mathbf{F}^{\text{el}}(\alpha) + \mathbf{F}^{\text{sr}}(\alpha) + \xi^{\text{f}}(\alpha)$ $\mathbf{T}(\alpha) = \mathbf{T}^{\text{el}}(\alpha) + \mathbf{T}^{\text{sr}}(\alpha) + \xi^{\text{t}}(\alpha)$

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Particles of same charge: repulsion



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Particles of opposite charges: attractive self-assembly



mutually induced dipoles

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Self-Assembly Mechanisms





(1) neutral & symmetric (2) induced dipole (3) attraction (4) repeated growth & dipolar

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Self-Assembly Mechanisms



(1) charged & dipole

(2) alignment (3) attraction (4) repeated growth & charged

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Particles of opposite charges: non-spherical shapes



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□ Stacking of charged particles under external fields



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Long-range force: dipolar particles



□ Long-range force: dipolar particles

$$\mathbf{P}(\mathbf{r},t;\alpha) = \mathbf{P}(t;\alpha) \eta(\mathbf{r},t;\alpha)$$

$$\mathbf{P}(\mathbf{r},t) = \sum_{\alpha} \mathbf{P}(\mathbf{r},t;\alpha)$$

$$\mathbf{E}(\mathbf{r}) = \mathbf{E}^{ex} - \frac{1}{\varepsilon_0} \int \frac{d^3k}{(2\pi)^3} \left[\mathbf{n} \cdot \tilde{\mathbf{P}}(\mathbf{k})\right] \mathbf{n} e^{i\mathbf{k}\cdot\mathbf{r}}$$

$$\mathbf{F}^{el}(\alpha) = \int_V \left[\mathbf{P}(\alpha) \cdot \nabla\right] \mathbf{E}(\mathbf{r}) \eta(\mathbf{r};\alpha) d^3r$$

$$\mathbf{T}^{el}(\alpha) = \int_V \mathbf{P}(\alpha) \times \mathbf{E}(\mathbf{r}) \eta(\mathbf{r};\alpha) d^3r$$

$$+ \int_V \left[\mathbf{r} - \mathbf{r}^c(\alpha)\right] \times \left\{ \left[\mathbf{P}(\alpha) \cdot \nabla\right] \mathbf{E}(\mathbf{r}) \right\} \eta(\mathbf{r};\alpha) d^3r$$

1 Long-range force: magnetic particles $\mathbf{M}(\mathbf{r},t) = \sum_{\alpha} \mathbf{M}(t;\alpha) \eta(\mathbf{r},t;\alpha) \qquad \mathbf{H}(\mathbf{r}) = \mathbf{H}^{ex} - \int \frac{d^{3}k}{(2\pi)^{3}} \left[\mathbf{n} \cdot \tilde{\mathbf{M}}(\mathbf{k})\right] \mathbf{n} e^{i\mathbf{k}\cdot\mathbf{r}}$ $\mathbf{F}^{mag}(\alpha) = \mu_{0} \int_{V} \left[\mathbf{M}(\alpha) \cdot \nabla\right] \mathbf{H}(\mathbf{r}) \eta(\mathbf{r};\alpha) d^{3}r$ $\mathbf{T}^{mag}(\alpha) = \mu_{0} \int_{V} \mathbf{M}(\alpha) \times \mathbf{H}(\mathbf{r}) \eta(\mathbf{r};\alpha) d^{3}r + \mu_{0} \int_{V} \left[\mathbf{r} - \mathbf{r}^{c}(\alpha)\right] \times \left\{\left[\mathbf{M}(\alpha) \cdot \nabla\right] \mathbf{H}(\mathbf{r})\right\} \eta(\mathbf{r};\alpha) d^{3}r$ *PFM2014, State College, PA Materials Science and Engineering*

Dipolar particles: agglomeration



















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Dipolar particles: field-directed self-assembly





































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Processing-Microstructure Relationship

- ❑ Mechanisms of Filler Particle Self-Assembly
 - Strongly anisotropic force that can be tuned by external field
 - Rigid-body motion (translation and rotation) of colloidal particles in liquids (water, organic solvent, polymer melt, etc.)



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D Phase field model of dielectric/magnetic composites



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Particle-Filled Polymer-Matrix Composites

Alignment of irregular-shaped functional filler particles

Dielectric: PZT fillers Electro-Optic: PbTiO₃ nanoparticles Magnetostrictive: Terfenol-D particles





Duenas et al, *J. Appl. Phys.*, **90**, 2433, 2001.



random



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needle-shaped irregular

Or et al, J. Appl. Phys., 93, 8510, 2003.



aligned

Model Formulation

Particles in multi-phase liquid: capillary forces

$$F = \int \left[f\left(\{c_{\alpha}\}, \{\eta_{\beta}\}\right) + \sum_{\alpha} \frac{1}{2} \kappa_{\alpha} |\nabla c_{\alpha}|^{2} \right] dV$$
Landau polynomial
$$f\left(\{c_{\alpha}\}, \{\eta_{\beta}\}\right) = A \left[\sum_{\alpha=1}^{2} \left(3c_{\alpha}^{4} - 4c_{\alpha}^{3}\right) + \sum_{\beta} \left(3\eta_{\beta}^{4} - 4\eta_{\beta}^{3}\right) + 6 \left(\chi c_{1}^{2}c_{2}^{2} + \sum_{\beta} \sum_{\alpha=1}^{2} \lambda_{\alpha}c_{\alpha}^{2}\eta_{\beta}^{2}\right) \right]$$

$$\frac{\partial c_{\alpha}}{\partial t} = \nabla \cdot \left(M_{\alpha} \nabla \frac{\delta F}{\delta c_{\alpha}} \right) \text{Cahn-Hilliard}$$

$$dp = c_{A} d \mu_{A} + c_{B} d \mu_{B}$$

$$p - p^{0} = c_{1}\mu_{1} + c_{2}\mu_{2}$$
Gibbs-Duhem
$$\mu_{\alpha} = \partial f / \partial c_{\alpha}$$

$$\Delta p = \frac{\gamma}{R} \text{ Young-Laplace}$$

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$$Description: Constraints of the second state of the second$$

Model Formulation

❑ Particles in multi-phase liquid: capillary forces

Laplace pressure

$$d\mathbf{F}^{\text{LP}}(\mathbf{r},\beta) = \kappa_{\text{P}} \nabla \eta(\mathbf{r},\beta) p(\mathbf{r}) dV$$



interfacial tension

$$d\mathbf{F}^{\mathrm{IT}}(\boldsymbol{\beta}) = \kappa_{\mathrm{T}} [\nabla c \times (\nabla c \times \nabla \eta_{\boldsymbol{\beta}})] dV$$
$$= \kappa_{\mathrm{T}} [(\nabla c \cdot \nabla \eta_{\boldsymbol{\beta}}) \nabla c - |\nabla c|^{2} \nabla \eta_{\boldsymbol{\beta}}] dV$$
$$\nabla c = c_{1} c_{2} (\nabla c_{1} - \nabla c_{2})$$



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Irregular-shaped particle at curved fluid interface





□ Particle self-assembly directed by fluid interface: encapsulation

negative pressure

zero pressure



positive pressure

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Bijel: bicontinuous interfacially jammed emulsion gels



(a) t*=4,000



(b) t*=20,000



(c) t*=40,000







(d) t*=60,000 *PFM2014*, *State College*, *PA*

(e) t*=200,000 Materials Science and Engineering



Bijel: bicontinuous interfacially jammed emulsion gels



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Capillary bridges for in-situ firming of colloidal crystals



100 nm, 10,000 Pa

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Simulation

Capillary bridges for in-situ firming of colloidal crystals



Time step=10,000

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